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## APPLICANTS

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## \*\* CONTINUING DATA \*\*\*\*\*

*W* This application is a CIP of 10/306,760 11/27/2002 PAT 6,697,749

## \*\* FOREIGN APPLICATIONS \*\*\*\*\*

*W* JAPAN 2003-011164 01/20/2003  
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## IF REQUIRED, FOREIGN FILING LICENSE GRANTED

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Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	STATE OR	SHEETS	TOTAL	INDEPENDENT
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Verified and Acknowledged Examiner's Signature <i>[Signature]</i> Initials	JAPAN	6	7	3

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## TITLE

Method for correcting measurement error, method of determining quality of electronic component, and device for measuring characteristic of electronic component

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